Search Notes

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	Application/Control No.	Applicant(s)/Patent under Reexamination
i	10/729,970	LIU ET AL.
	Examiner	Art Unit

2838

Adolf Berhane

	SEAR	CHED	
Class	Subclass	Date	Examiner
363	15		
	16		
	17		
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	21.04		
	67		
	69		
	71	5/10/2005	AB

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
363	16		
	69	5/10/2005	AB

SEARCH (INCLUDING SEAR		<b>(</b> )
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